



## General Features

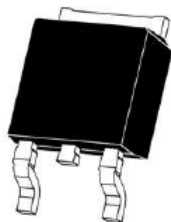
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation

## Application

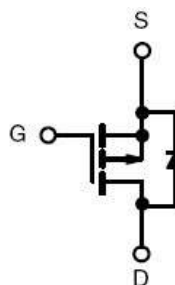
- Load switch
- Battery protection

## Product Summary

BVDSS	-20	V
RDS(on)Typ.@VGS=-4.5V	6.3	mΩ
ID	-50	A



TO-252-2L top view



Schematic diagram

## Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Drain Current-Continuous	$I_D$	-50	A
Drain Current-Continuous( $T_C=100^\circ\text{C}$ )	$I_D(100)^\circ\text{C}$	-35	A
Pulsed Drain Current	$I_{DM}$	-200	A
Maximum Power Dissipation	$P_D$	80	W
Derating factor		0.64	W/ $^\circ\text{C}$
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 150	$^\circ\text{C}$

## Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.6	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	50	$^\circ\text{C}/\text{W}$

## Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

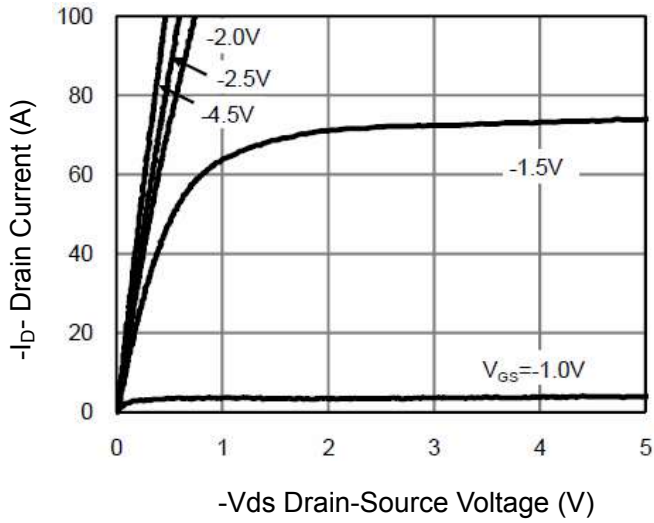
Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V	-	-	±100	nA
<b>On Characteristics (Note 3)</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-0.3	-0.8	-1.2	V
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A	-	6.3	7	mΩ
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-20A	-	9.0	10	
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-20A	-	17	22	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A	80	-	-	S
<b>Dynamic Characteristics (Note4)</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =-10V, V <sub>GS</sub> =0V, F=1.0MHz	-	3673	-	PF
Output Capacitance	C <sub>oss</sub>		-	606	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	467	-	PF
<b>Switching Characteristics (Note 4)</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =-10V, R <sub>GEN</sub> =3Ω V <sub>GS</sub> =-4.5V, R <sub>L</sub> =0.5Ω	-	18	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	42	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	85	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	23	-	nS
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =-10V, I <sub>D</sub> =-20A, V <sub>GS</sub> =-4.5V	-	55	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	10	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	15	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =-20A	-	-	-1.2	V
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	-50	A
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25°C, I <sub>F</sub> = -10A di/dt = 100A/μs (Note3)	-	47	-	nS
Reverse Recovery Charge	Q <sub>rr</sub>		-	53	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

### Notes:

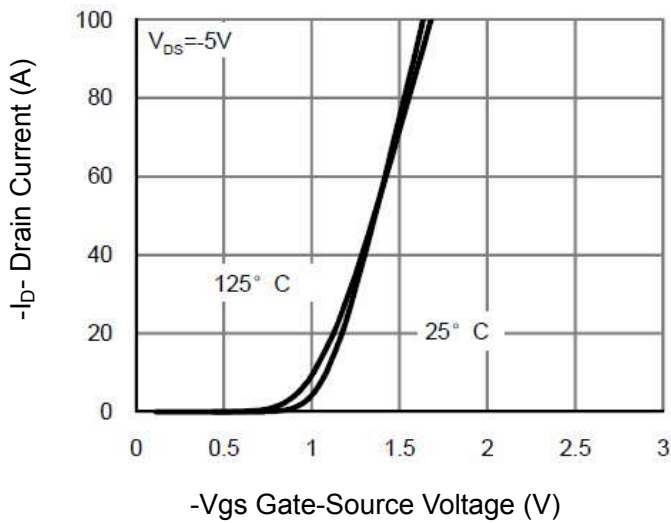
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production



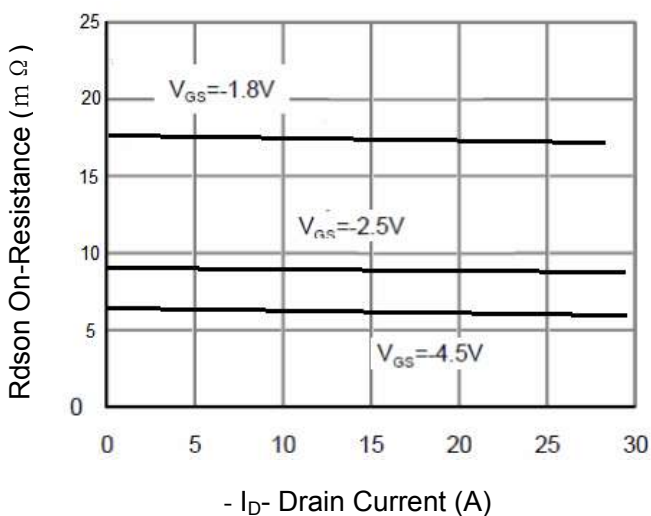
### Typical Electrical and Thermal Characteristics (Curves)



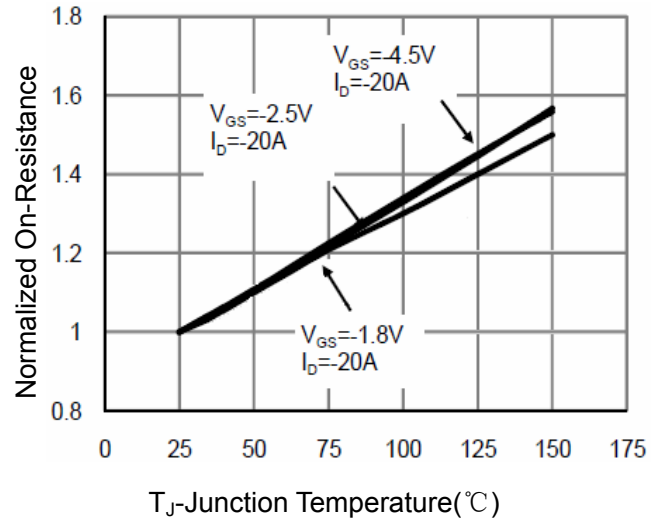
**Figure 1 Output Characteristics**



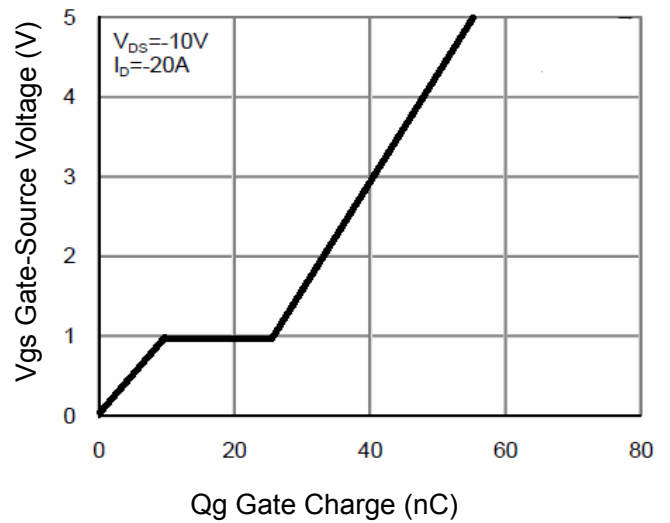
**Figure 2 Transfer Characteristics**



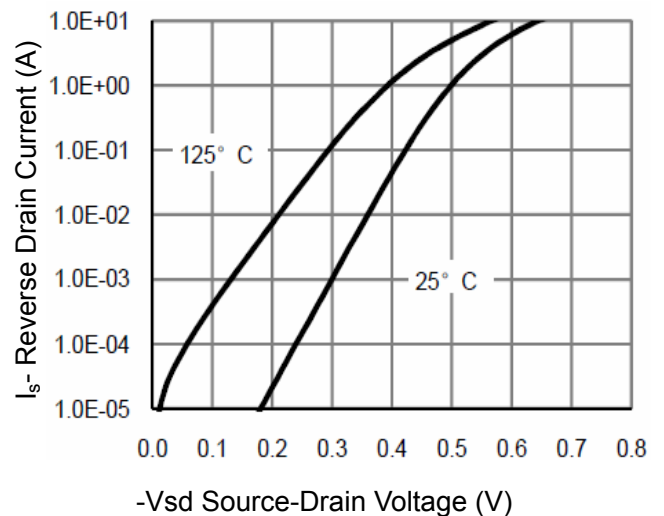
**Figure 3 Rdson- Drain Current**



**Figure 4 Rdson-Junction Temperature**



**Figure 5 Gate Charge**



**Figure 6 Source- Drain Diode Forward**

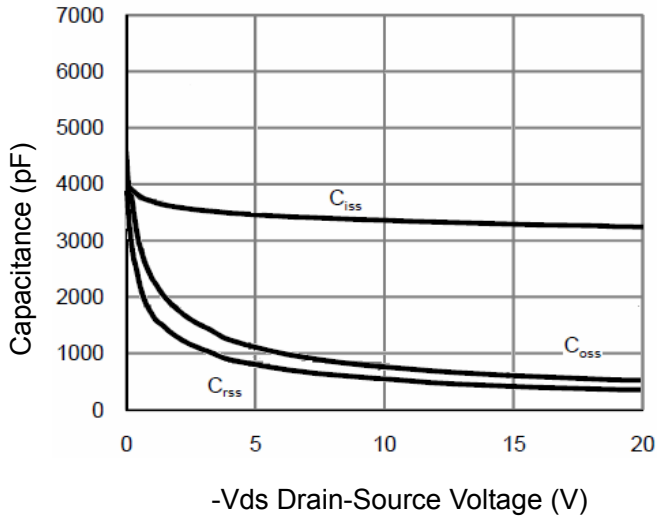


Figure 7 Capacitance vs Vds

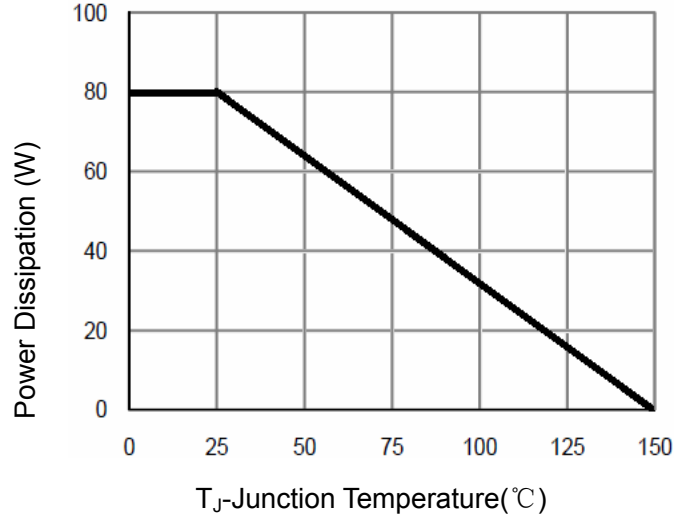


Figure 9 Power De-rating

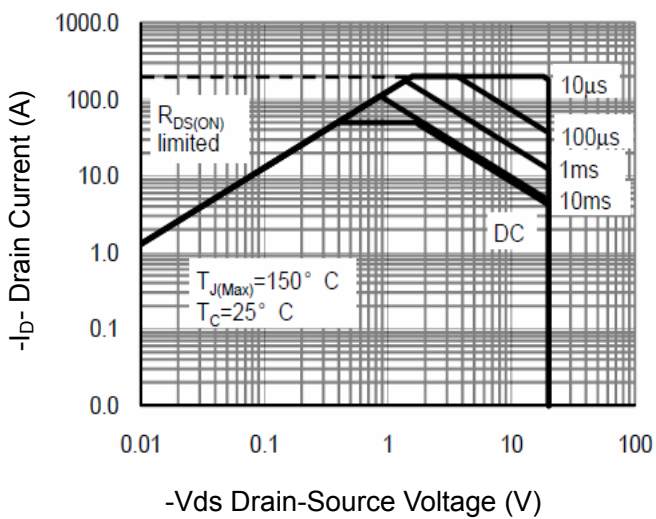


Figure 8 Safe Operation Area

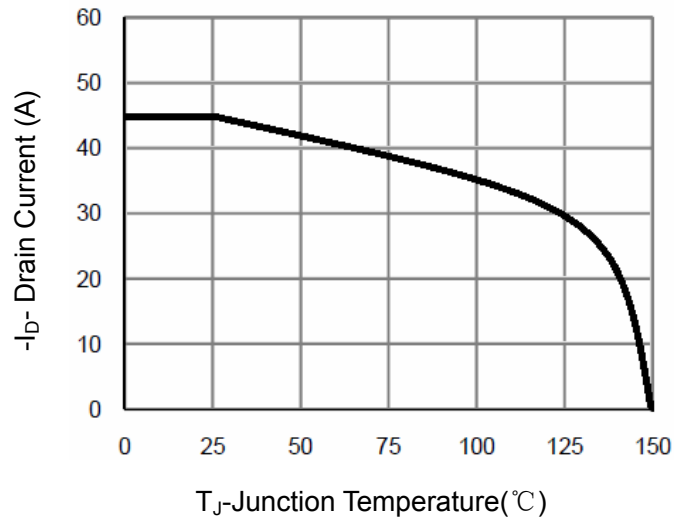


Figure 10 -Current De-rating

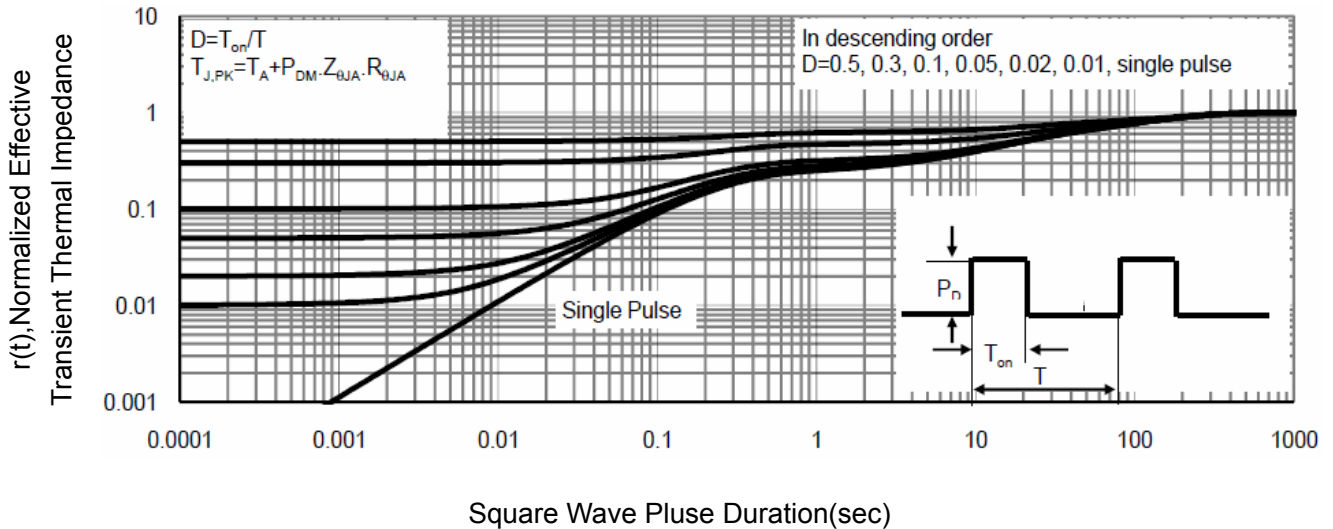
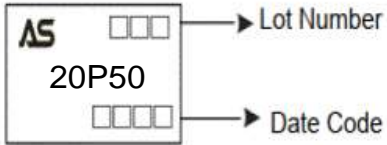


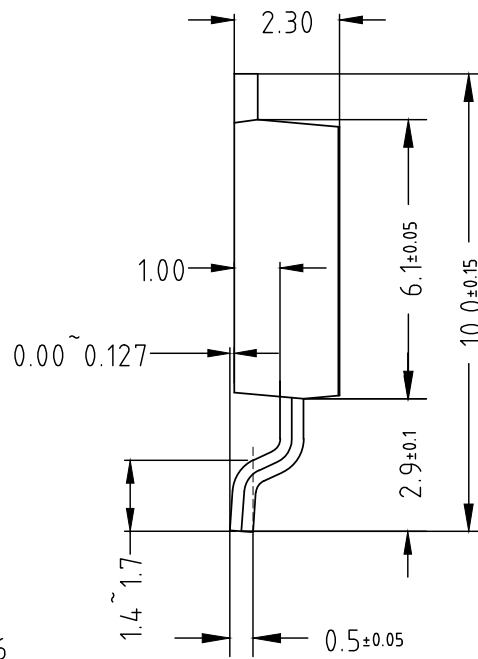
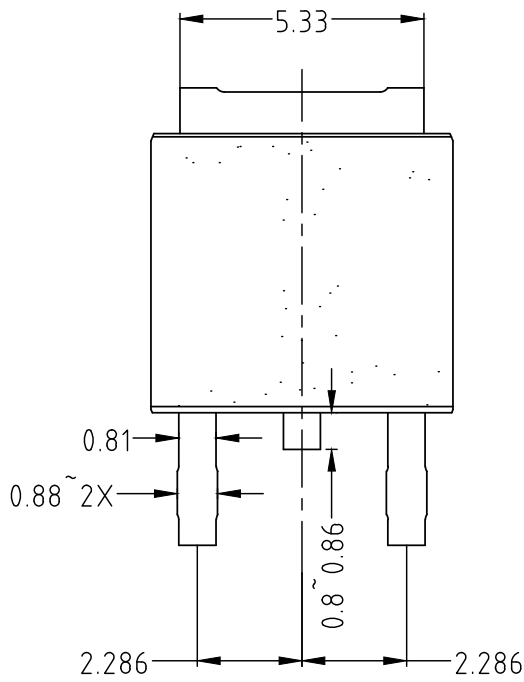
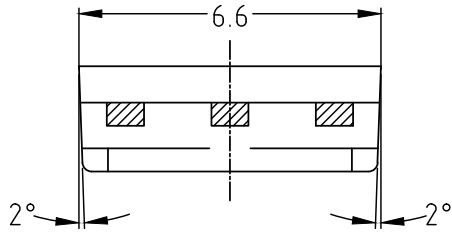
Figure 11 Normalized Maximum Transient Thermal Impedance

## Ordering and Marking Information

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM20P50KQ-R	20P50	TO-252	Tape&Reel	2500/Reel

PACKAGE	MARKING
TO-252	 <p>AS    □□    → Lot Number  20P50  □□□□    → Date Code</p>

# TO-252



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